

**Search Notes**

Application/Control No.

10/730,986

Examiner

Thien F. Tran

Applicant(s)/Patent under  
Reexamination

SAKAKURA ET AL.

Art Unit

2811

**SEARCHED**

Class	Subclass	Date	Examiner
257	59, 72	2/17/2005	TT
438	48, 128	2/17/2005	TT
438	149, 151	2/17/2005	TT
438	157, 283	2/17/2005	TT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
438	149, 151	2/17/2005	TT
438	157, 283	2/17/2005	TT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR